

**Search Notes****Application/Control No.**

10/775,858

**Examiner**

X. L. Bautista

**Applicant(s)/Patent under Reexamination**

MULVEY ET AL.

**Art Unit**

2179

**SEARCHED**

Class	Subclass	Date	Examiner
715	702,705	12/14/2006	XB
	708-710		
	764,765		
	810-812		
	816,864		
	512		
345	156-158		
	169,173		

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
715	702,708	12/14/2006	XB
	765,811		
	812,816		
345/156,157			

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST Search	12/14/2006	XB
Databases Searched: US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB		
Interference Search History		
ip.com		
Google		
IEEE Xplore		